

Search Notes



Application/Control No.

10/803,989

Examiner

Sin J. Lee

Applicant(s)/Patent under
Reexamination

TAKAHASHI ET AL

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	271.1	5-29-05	SJL
↓	278.1	↓	↓
↓	270.1	↓	↓
↓	944	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Structure Search for formula (I) of cl. #2	11-7-05	SJL
Structure Search for formula (I-b) of cl. #5	↓	↓
Structure Search for cl. #2 ± cl. #5 Polymers	11-7-06	SJL